

# 2SK3089

Chopper Regulator DC-DC Converter, and Motor Drive Applications

- Low drain-source ON resistance :  $R_{DS(ON)} = 25 \text{ m}\Omega$  (typ.)
- High forward transfer admittance :  $|Y_{fs}| = 20 \text{ S}$  (typ.)
- Low leakage current :  $I_{DSS} = 100 \text{ }\mu\text{A}$  (max) ( $V_{DS} = 30 \text{ V}$ )
- Enhancement mode :  $V_{th} = 1.5\sim 3.0 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $I_D = 1 \text{ mA}$ )

## Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

| Characteristics                                      |                | Symbol    | Rating   | Unit             |
|--|----------------|-----------|----------|------------------|
| Drain-source voltage                                 |                | $V_{DSS}$ | 30       | V                |
| Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ ) |                | $V_{DGR}$ | 30       | V                |
| Gate-source voltage                                  |                | $V_{GSS}$ | $\pm 20$ | V                |
| Drain current  | DC (Note 1)    | $I_D$     | 40       | A                |
|  | Pulse (Note 1) | $I_{DP}$  | 80       |                  |
| Drain power dissipation ( $T_c = 25^\circ\text{C}$ ) |                | $P_D$     | 50       | W                |
| Single pulse avalanche energy (Note 2)               |                | $E_{AS}$  | 134      | mJ               |
| Avalanche current                                    |                | $I_{AR}$  | 40       | A                |
| Repetitive avalanche energy (Note 3)                 |                | $E_{AR}$  | 5        | mJ               |
| Channel temperature                                  |                | $T_{ch}$  | 150      | $^\circ\text{C}$ |
| Storage temperature range                            |                | $T_{stg}$ | -55~150  | $^\circ\text{C}$ |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

## Thermal Characteristics

| Characteristics                        | Symbol         | Max  | Unit                        |
|--|----------------|------|-----------------------------|
| Thermal resistance, channel to case    | $R_{th(ch-c)}$ | 2.5  | $^\circ\text{C} / \text{W}$ |
| Thermal resistance, channel to ambient | $R_{th(ch-a)}$ | 83.3 | $^\circ\text{C} / \text{W}$ |

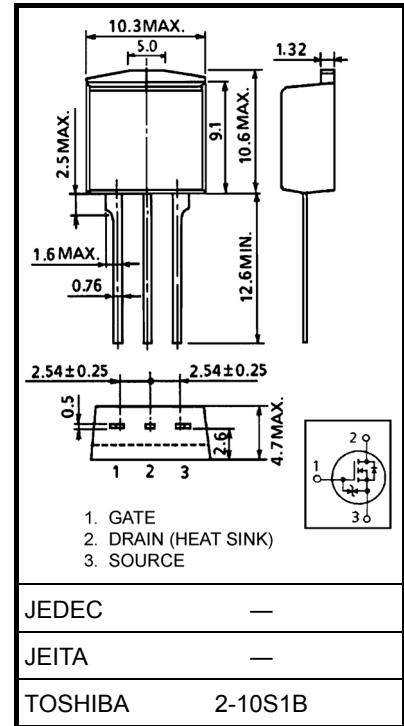
Note 1: Ensure that the channel temperature does not exceed  $150^\circ\text{C}$ .

Note 2:  $V_{DD} = 25 \text{ V}$ ,  $T_{ch} = 25^\circ\text{C}$  (initial),  $L = 60 \text{ }\mu\text{H}$ ,  $R_G = 25 \text{ }\Omega$ ,  $I_{AR} = 40 \text{ A}$

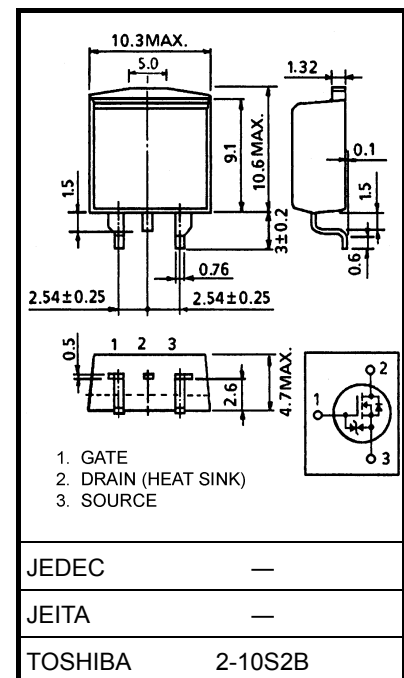
Note 3: Repetitive rating pulse width limited by maximum channel temperature.

This transistor is an electrostatic-sensitive device. Please handle with caution.

Unit: mm



Weight: 1.5 g (typ.)



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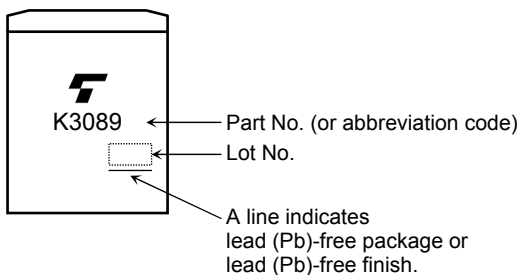
## Electrical Characteristics (Ta = 25°C)

| Characteristics                                 |               | Symbol        | Test Condition  | Min                                     | Typ. | Max      | Unit             |
|---|---------------|---------------|---|---|------|----------|------------------|
| Gate leakage current                            |               | $I_{GSS}$     | $V_{GS} = \pm 16\text{ V}, V_{DS} = 0\text{ V}$                       | —                                       | —    | $\pm 10$ | $\mu\text{A}$    |
| Drain cut-off current                           |               | $I_{DSS}$     | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$                           | —                                       | —    | 100      | $\mu\text{A}$    |
| Drain-source breakdown voltage                  |               | $V_{(BR)DSS}$ | $I_D = 10\text{ mA}, V_{GS} = 0\text{ V}$                             | 30                                      | —    | —        | V                |
| Gate threshold voltage                          |               | $V_{th}$      | $V_{DS} = 10\text{ V}, I_D = 1\text{ mA}$                             | 1.5                                     | —    | 3.0      | V                |
| Drain-source ON resistance                      |               | $R_{DS(ON)}$  | $V_{GS} = 10\text{ V}, I_D = 20\text{ A}$                             | —                                       | 25   | 30       | $\text{m}\Omega$ |
| Forward transfer admittance                     |               | $ Y_{fs} $    | $V_{DS} = 10\text{ V}, I_D = 20\text{ A}$                             | 10                                      | 20   | —        | S                |
| Input capacitance                               |               | $C_{iss}$     | $V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$         | —                                       | 920  | —        | pF               |
| Reverse transfer capacitance                    |               | $C_{rss}$     |   | —                                       | 290  | —        |                  |
| Output capacitance                              |               | $C_{oss}$     |   | —                                       | 420  | —        |                  |
| Switching time                                  | Rise time     | $t_r$         |   | —                                       | 10   | —        | ns               |
|   | Turn-on time  | $t_{on}$      |   | —                                       | 17   | —        |                  |
|   | Fall time     | $t_f$         |   | —                                       | 40   | —        |                  |
|   | Turn-off time | $t_{off}$     |   | Duty $\leq 1\%$ , $t_w = 10\mu\text{s}$ | —    | 80       |                  |
| Total gate charge (Gate-source plus gate-drain) |               | $Q_g$         | $V_{DD} \approx 24\text{ V}, V_{GS} = 10\text{ V}, I_D = 40\text{ A}$ | —                                       | 23   | —        | nC               |
| Gate-source charge                              |               | $Q_{gs}$      |   | —                                       | 15   | —        |                  |
| Gate-drain ("miller") charge                    |               | $Q_{gd}$      |   | —                                       | 8    | —        |                  |

## Source-Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics                           | Symbol    | Test Condition                              | Min | Typ. | Max  | Unit |
|---|-----------|---|-----|------|------|------|
| Continuous drain reverse current (Note 1) | $I_{DR}$  | —   | —   | —    | 40   | A    |
| Pulse drain reverse current (Note 1)      | $I_{DRP}$ | —   | —   | —    | 80   | A    |
| Forward voltage (diode)                   | $V_{DSF}$ | $I_{DR} = 40\text{ A}, V_{GS} = 0\text{ V}$ | —   | —    | -1.7 | V    |
| Reverse recovery time                     | $t_{rr}$  | $I_{DR} = 40\text{ A}, V_{GS} = 0\text{ V}$ | —   | 80   | —    | ns   |
| Reverse recovery charge                   | $Q_{rr}$  | $dI_{DR} / dt = 50\text{ A} / \mu\text{s}$  | —   | 130  | —    | nC   |

## Marking



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